Product data sheet

1 General description

The TEA18361T is a controller IC for low-cost switched-mode power supplies (SMPS). It is intended for flyback topologies. The built-in green functions provide high efficiency at all power levels.

At high power levels, the flyback operates in quasi-resonant (QR) mode. At lower power levels, the controller switches to frequency reduction (FR) or discontinuous conduction mode (DCM) and limits the peak current to approximately 25 % of the maximum peak current. Valley switching is used in all operating modes.

At low power levels, when the flyback switching frequency drops to below 25 kHz, the flyback converter switches to burst mode. A special burst mode has been integrated which reduces the optocurrent to a minimum level, ensuring high efficiency at low power and excellent no-load power performance. As the switching frequency in this mode has a minimum value of 25 kHz while the burst frequency is below 800 Hz, the frequencies are outside the audible range. During the non-switching phase of the burst mode, the internal IC supply current is minimized for further efficiency optimization.

The TEA18361T includes an accurate overpower protection (OPP). The OPP enables the controller to operate in overpower situations for a limited time. If the output is shorted, the system switches to low-power mode where the output power is limited to a lower level.

The TEA18361T is manufactured in a high-voltage silicon-on-insulator (SOI) process. The SOI process combines the advantages of a low-voltage process (accuracy, high-speed protection, functions, and control), while maintaining the high-voltage capabilities (high-voltage start-up, low standby power, and an integrated X-capacitor discharge function).

The TEA18361T enables low-cost, highly efficient, and reliable supplies for power requirements up to 75 W to be designed with a minimum number of external components.

All values mentioned in this data sheet are typical values, unless otherwise specified.

2 Features and benefits

2.1 General features

- SMPS controller IC for low-cost applications
- Large supply voltage range (up to 30 V)
- Integrated high-voltage startup
- Continuous VCC regulation during startup and protection via the HV pin, allowing a minimum VCC capacitor value
- · Reduced optocurrent in burst mode enabling low no-load power consumption
- · Operating frequencies in all operating modes are outside the audible area



- Integrated X-capacitor discharge
- · Adjustable soft start
- Power-down mode via the PROTECT pin1

2.2 Green features

- Low supply current during normal operation (0.6 mA without load)
- Low supply current during non-switching state in burst mode (0.2 mA)
- Valley switching for minimum switching losses
- Frequency reduction with fixed minimum peak current to maintain high efficiency at low output power levels

2.3 Protection features

- Mains voltage independent overpower protection (OPP)
- Overtemperature protection (OTP)
- · Integrated overpower timeout
- · Integrated restart timer for system fault conditions
- · Continuous mode protection using demagnetization detection
- Accurate overvoltage protection (OVP)
- General-purpose input for latched protection; for use with system overtemperature protection (OTP)
- · Driver maximum on-time protection

3 Applications

• Applications requiring efficient and cost-effective power supply solutions up to 75 W

4 Ordering information

Table 1. Ordering information

Type number	Package	ackage				
	Name	Description	Version			
TEA18361T/2	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1			

5 Marking

Table 2. Marking

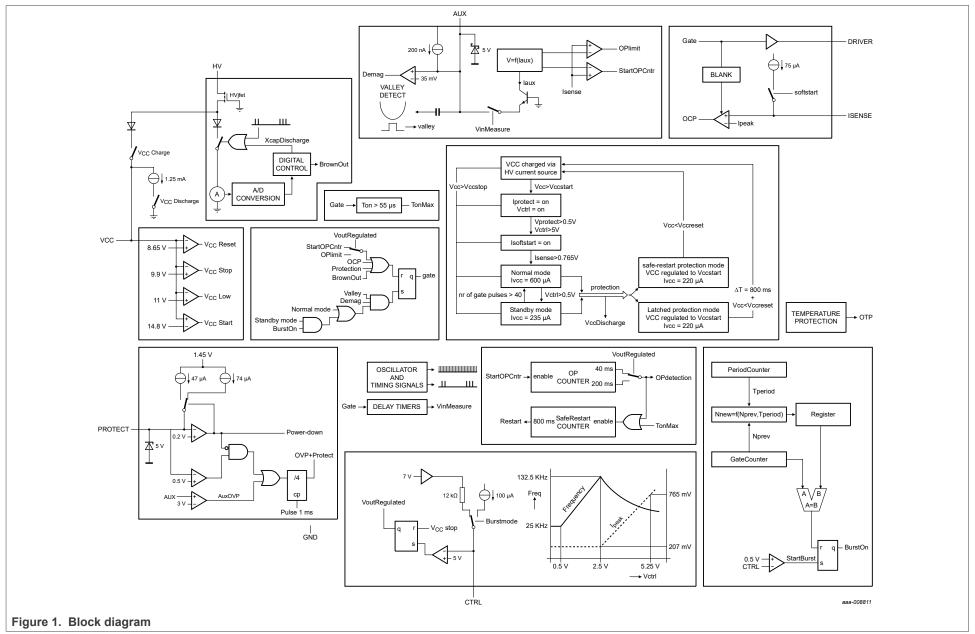
Type number	Marking code
TEA18361T/2	TEA18361T

6 Block diagram

TEA18361_2

NXP Semiconductors TEA18361T/2

GreenChip SMPS control IC



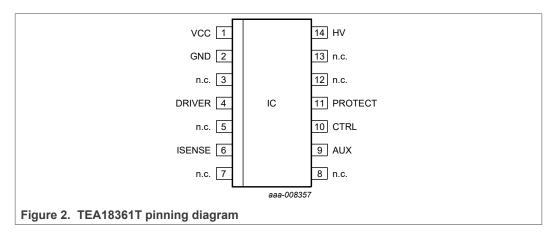
TEA18361_2

All information provided in this document is subject to legal disclaimers.

© 2022 NXP B.V. All rights reserved.

7 Pinning information

7.1 Pinning



7.2 Pin description

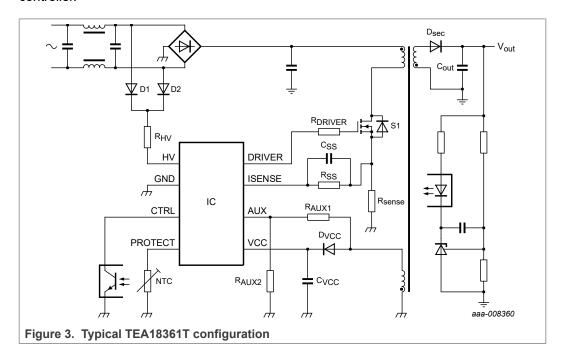
Table 3. Pin descriptions

Pin	Pin number	Description
VCC	1	supply voltage
GND	2	ground
n.c.	3	not connected
DRIVER	4	gate driver output
n.c.	5	not connected
ISENSE	6	current sense input
n.c	7	not connected
n.c.	8	not connected
AUX	9	auxiliary winding input for demagnetization timing, valley detect, overpower correction, and OVP
CTRL	10	control input
PROTECT	11	general-purpose protection input; pin for power-down mode
n.c.	12	high-voltage safety spacer; not connected
n.c.	13	high-voltage safety spacer; not connected
HV	14	high voltage start-up; active X-capacitor discharge

8 Functional description

8.1 General control

<u>Figure 3</u> shows a typical configuration of the TEA18361T, including flyback circuit controller.

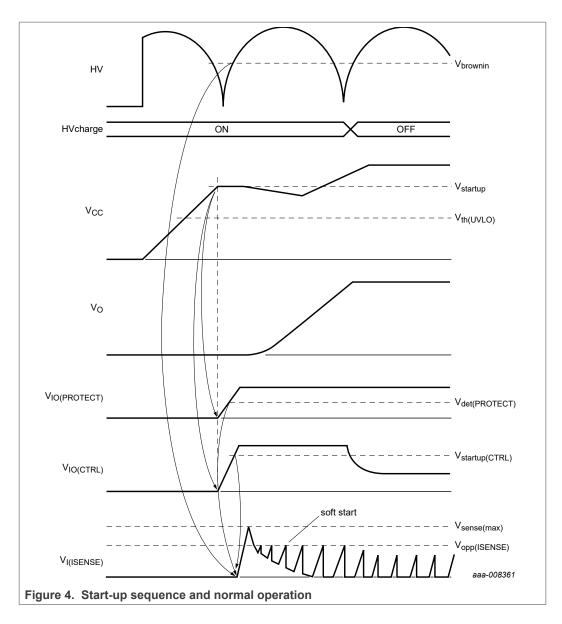


8.1.1 Start-up and undervoltage lockout (UVLO)

Initially, the capacitor on the VCC pin is charged from the high-voltage mains using the HV pin. As long as V_{CC} is below $V_{startup}$, the IC current consumption is minimized to 40 μ A.

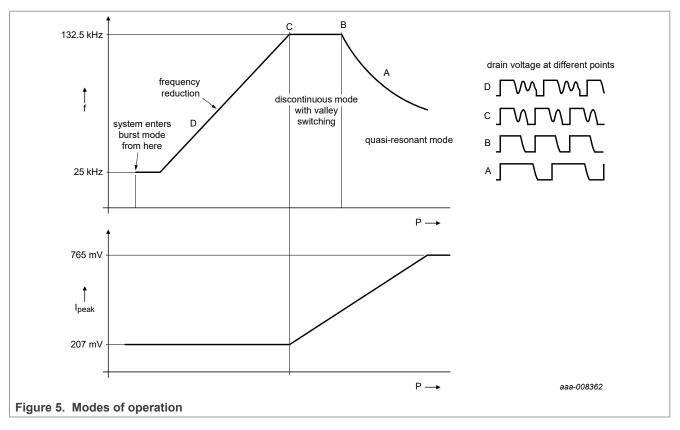
When V_{CC} reaches the $V_{startup}$ level, the control logic activates the internal circuitry. The IC then waits for the PROTECT pin to reach $V_{det(PROTECT)} + V_{det(hys)PROTECT}$, the CTRL pin to reach $V_{startup(CTRL)}$, and the mains voltage to increase to exceed the brownin level. When all these conditions are met, the soft start capacitor on the ISENSE pin (C_{SS} in Figure 3) is charged. The system starts switching. In a typical application, the auxiliary winding of the transformer takes over the supply voltage.

During the start-up period, the VCC pin is continuously regulated to the V_{startup} level using the HV charge current until the output voltage is at its regulation level, which is detected via the CTRL pin. In this way, the VCC capacitor value can be limited. Due to the limited current capability from the HV pin and depending on the mains voltage, the voltage on pin VCC can still drop slightly during the start-up period.



8.2 Modes of operation

The TEA18361T operates in quasi-resonant mode, discontinuous conduction mode, or burst mode (see <u>Figure 5</u>). The auxiliary winding of the flyback transformer provides demagnetization and valley detection.



At high output power, the converter operates in quasi-resonant mode. The next converter cycle starts after demagnetization of the transformer and detection of the valley. In quasi-resonant mode, switching losses are minimized because the external MOSFET is switched on while the drain-source voltage is minimal.

To prevent high-frequency operation at lower loads, the quasi-resonant operation switches to discontinuous conduction mode (DCM) operation with valley skipping once the frequency reaches its maximum. This frequency limit reduces the MOSFET switch-on losses and conducted EMI.

At medium power levels, the controller enters frequency reduction (FR) mode. A voltage controlled oscillator (VCO) controls the frequency. The minimum frequency in this mode is reduced to 25 kHz. During FR mode, the primary peak current is kept at an adjustable minimum level to maintain high efficiency. Valley switching is also active in this mode.

At low power, the converter enters the burst mode. In burst mode, the minimum switching frequency is 25 kHz.

8.3 Supply management

All internal reference voltages are derived from a temperature-compensated onchip band gap circuit. Internal reference currents are derived from a trimmed and temperature-compensated current reference circuit.

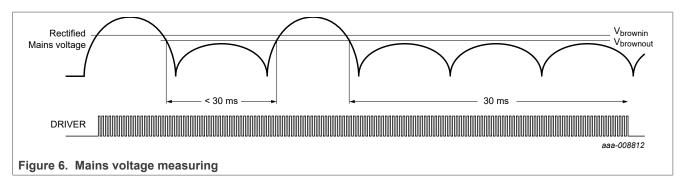
8.4 Mains voltage measuring

In a typical application, the mains input voltage is measured using the HV pin. Once per ms the mains voltage is measured by pulling down the HV pin to ground and measuring its current. This current then reflects the input voltage.

The system determines if the mains voltage exceeds the brownin level or it is disconnected using an analog-to-digital converter and digital control (see <u>Figure 1</u>).

Once the mains is above the brownin level, the system is allowed to start switching (see Figure 6).

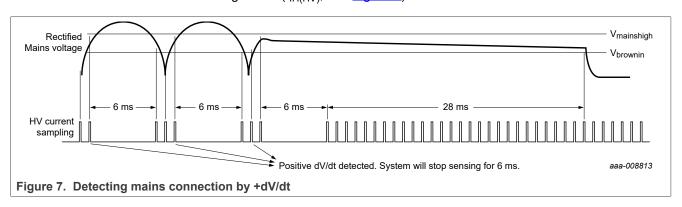
If the mains voltage is continuously below the brownout level for at least 30 ms, a brownout is detected and the system immediately stops switching. This period is required to avoid that the system stops switching due to the zero crossings of the mains or during a short mains interruption.



When the mains voltage is measured by pulling the HV pin to ground, the digital control calculates if there is a positive dV/dt at the mains. A positive dV/dt implies that a mains is connected.

Once a mains is detected, the measuring of the mains input voltage is stopped for 6 ms to improve efficiency. In burst mode, this waiting period is enlarged to 97 ms to improve efficiency.

A positive dV/dt is measured when succeeding samples cross the brownin level ($I_{bi(HV)}$) or the mains high level ($I_{IH(HV)}$; see <u>Figure 7</u>).



If the system does not detect a positive dV/dt for 28 ms, it assumes that the mains is disconnected. In that case, the HV pin is continuously pulled to ground, discharging the external X-capacitor.

8.5 Auxiliary winding

The VCC pin is connected via a diode and a capacitor to the auxiliary winding to supply the control IC efficiently.

To detect demagnetization, valley, and input and output voltage, the auxiliary winding is connected to the AUX pin via a resistive divider (see <u>Figure 3</u>). Each switching cycle is divided in sections. During each section, the system knows if the voltage or current out of the AUX pin reflects the demagnetization, valley, input, or output voltage (see <u>Figure 8</u>).

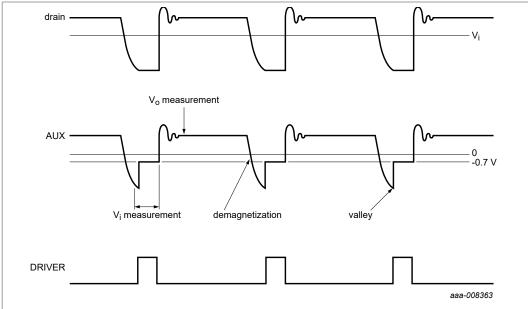


Figure 8. AUX pin used for demagnetization, valley, and input and output voltage measurement

When the external MOSFET is switched on, the voltage at the auxiliary winding reflects the input voltage. The AUX pin is clamped to -0.7 V. The output current is a measure of the input voltage. This current value is internally used for an accurate OPP.

The demagnetization, valley, and output voltages are measured as a voltage on the AUX pin. In this way, the input voltage measurement and OVP can be adjusted independently.

8.6 Protection

If a protection is triggered, the controller stops switching. Depending on the protection triggered and the IC version, the protection causes a restart or latches the converter to an off state (See <u>Table 4</u>).

To avoid false triggering, some protections have a built-in delay.

Table 4. Protections

Protection	Delay	Action	V _{CC} regulated
AUX open	no	wait until AUX is connected	no
brownout	30 ms	wait until V _{mains} > V _{brownin}	yes
maximum on-time	no	safe restart 800 ms	yes

TEA18361_2

All information provided in this document is subject to legal disclaimers.

© 2022 NXP B.V. All rights reserved

Table 4. Protections...continued

Protection	Delay	Action	V _{CC} regulated
OTP internal	no	latch	yes
OTP via the PROTECT pin	2 ms to 4 ms	latch	yes
OVP via the AUX pin	4 driver pulses ^[1]	latch	yes
overpower compensation	no	via AUX; cycle-by- cycle	-
overpower timeout	40 ms or 200 ms	safe restart 800 ms	yes
overpower + UVLO	no	safe restart 800 ms	yes
overcurrent protection	blanking time	cycle-by-cycle	no
UVLO	no	Wait until V _{CC} > V _{startup}	yes

^[1] When the voltage on the PROTECT pin is between V_{th(pd)(PROTECT)} and V_{det(PROTECT)}, the clock of the delay counter is changed from the driver pulse to 1 ms internal pulse.

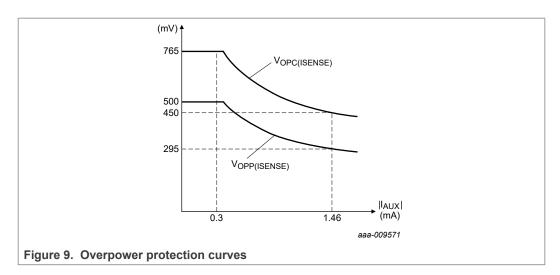
When the system stops switching, the VCC pin is not supplied via the auxiliary winding anymore. Depending on the protection triggered, the VCC is regulated to V_{startup} via the HV pin (see <u>Table 4</u>).

Releasing the latched protections or shortening the safe restart timer can be achieved by removing or shorting the mains voltage. It is called a fast latch reset. It is used to shorten the test time in production (See <u>Section 8.6.8</u>).

8.6.1 Overpower protection (OPP)

The overpower function is used to realize a maximum output power which is nearly constant over the full input mains.

The overpower compensation circuit measures the input voltage via the AUX pin and outputs two reference voltages (see Figure 1). If the measured voltage at the ISENSE pin exceeds the highest reference voltage ($V_{opc(ISENSE)}$), the DRIVER output is pulled low. If the measured ISENSE voltage exceeds the lower reference voltage ($V_{opp(ISENSE)}$), the overpower counter starts. Both reference voltages depend on the measured input voltage. In this way, the system allows 150 % overpower over the rated power on a cycle-by-cycle base. 100 % overpower triggers the overpower counter of 200 ms. Figure 9 shows the overpower protection curves.



During system start-up, the maximum overpower is limited to 100 % and the maximum timeout period is lowered to 40 ms. When the output voltage is within its regulation level (voltage on the CTRL pin is below 5 V), the maximum overpower is switched to 150 %. The maximum timeout period returns to 200 ms, limiting the output power to a minimum at a shorted output. Lowering the maximum output power and shortening the overpower timer ensure that the input power of the system is limited to < 5 W at a shorted output.

Due to the limited output power, if the load requires more than 150 %, the output voltage drops. As a result, the V_{CC} voltage drops as well and UVLO can be triggered. To retain the same response in an overpower situation (whether UVLO is triggered or not), the system enters the protection mode (latch or safe restart) when overpower + UVLO is detected. The system entering the protection mode does not depend on the value of the OP counter.

8.6.2 Overvoltage protection (OVP)

An accurate output OVP is implemented by measuring the voltage at the AUX pin during the secondary stroke. As the auxiliary winding voltage is a well-defined replica of the output voltage, the external resistor divider ratio R_{AUX2} / ($R_{AUX1} + R_{AUX2}$) can adjust the OVP level.

An internal counter of 4 gate pulses prevents false OVP detection which can occur during ESD or lightning events.

8.6.3 Protection input (PROTECT pin)

The PROTECT pin is a general-purpose input pin. It can be used to switch off the converter (latched protection). The converter is stopped when the voltage on this pin is pulled below $V_{det(PROTECT)}$ (0.5 V).

The PROTECT pin can be used to create an OTP function by connecting a negative temperature coefficient (NTC) resistor to this pin. A voltage on the PROTECT pin lower than 0.5 V detects overtemperature. The PROTECT current (maximum 74 μ A) flowing through the external NTC resistor creates the voltage. The PROTECT voltage is clamped to maximum 1.45 V. At room temperature, the resistance value of the NTC resistor is much higher than at high temperature. Due to the clamp, the current out of the PROTECT pin is 1.45 V divided by the resistance, which is significantly lower than 74 μ A.

A filter capacitor can be connected to this pin.

TEA18361_2

All information provided in this document is subject to legal disclaimers.

© 2022 NXP B.V. All rights reserved

To avoid false triggering, an internal filter of 2 ms to 4 ms is applied.

The PROTECT pin can also be a power-down mode pin (see Section 8.10).

8.6.4 Overtemperature protection (OTP)

If the junction temperature exceeds the thermal temperature shutdown limit, integrated OTP ensures that the IC stops switching. OTP is a latched protection.

8.6.5 Maximum on-time

The controller limits the on-time of the external MOSFET to $55 \, \mu s$. When the on-time is longer, the IC stops switching and enters safe restart mode.

8.6.6 Safe restart

If a protection is triggered and the system enters the safe restart mode, the system restarts after 800 ms. Because the system is not switching, the VCC pin is supplied from the mains via the HV pin.

After the 800 ms, the control IC measures the mains voltage. If the mains voltage exceeds the brownin level, the control IC activates the PROTECT pin current source and the internal voltage sources connected to the CTRL pin. When the voltages on these pins reach a minimum level, the soft-start capacitor on the ISENSE pin is charged and the system starts switching again.

The V_{CC} is continuously regulated to the $V_{startup}$ level until the output voltage is within the regulation level again.

8.6.7 Latched protection

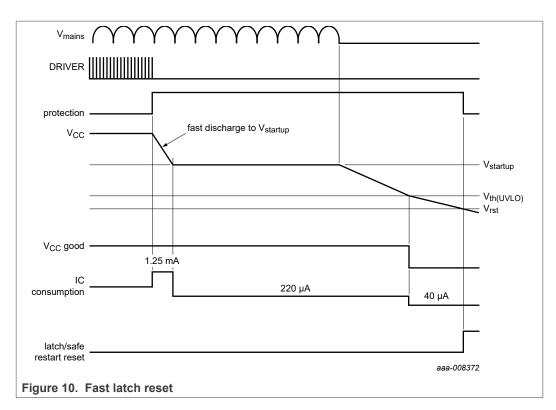
If a protection is triggered and the system enters the latched protection mode, the V_{CC} is continuously regulated to the $V_{startup}$ level via the HV current source. As long as the AC voltage remains, the system does not switch.

Removing the mains for a short time is the only possibility to restart the system.

8.6.8 Fast latch reset

Fast latch reset is a simple and fast method to reset the system when it is in latched protection mode or safe restart mode. This function is used during production testing.

When the latched protection mode or safe restart mode is triggered, an internal current source ($I_{CC(dch)}$; see Figure 10) fast-discharges the voltage on pin VCC. If the VCC voltage is high, the fast discharge avoids an additional waiting period. When shorting the mains, the waiting period is only the time of the discharge from $V_{startup}$ to V_{rst} .



Using a 10 μ F VCC capacitor, the fast latch reset time is below 0.6 s. If the mains is not shorted but removed, a discharge of the X-capacitor can cause an additional waiting time.

8.7 Burst mode operation (CTRL pin)

The controller enters the burst mode when a low output power causes the voltage on the CTRL pin to drop to below 0.5 V.

During normal operation, the primary optocurrent can be calculated with Equation 1:

$$I_{opto} = \frac{(7V - V_{IO(CTRL)})}{12k\Omega} \tag{1}$$

The implication is that without any additional measure, the maximum primary optocurrent in burst mode is:

$$I_{opto} = \frac{(7V - 0V)}{12k\Omega} = 583\mu A \tag{2}$$

Depending on the optocoupler used, the secondary optocurrent is even higher.

To achieve minimum no-load input power, the internal voltage (7 V) is regulated to a value that causes the primary optocurrent value to be 100 μA when the system is in burst mode. The secondary optocurrent is then automatically also within this lower range. If the IC detects that the optocurrent is lower than 80 μA , the internal voltage is increased faster to achieve a small output voltage undershoot at a positive load step. Once the system enters normal operation mode, the internal voltage is slowly increased to 7 V again.

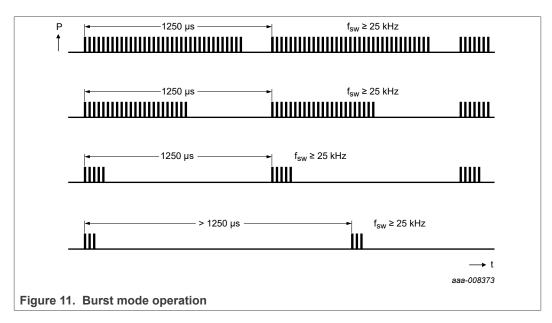
To avoid audible noise, a special digital burst mode is implemented. The minimum switching frequency in this mode is 25 kHz. The burst mode repetition rate has a target frequency of 800 Hz (1250 µs; see Figure 11).

The requested output power defines the number of pulses at each burst period. At higher output power, the number of switching pulses increases. At low load, it decreases.

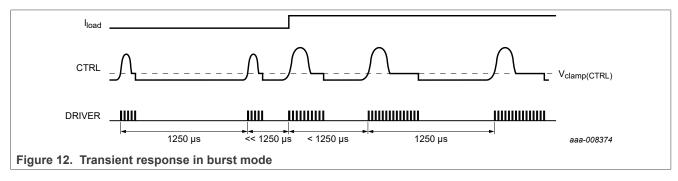
The digital circuit defines the number of burst cycles so that the burst frequency is below the audible range (800 Hz) and the switching frequency exceeds the audible range (25 kHz). Any audible noise is avoided.

The minimum number of switching cycles is set to 3 to ensure good efficiency at very low loads. To regulate the output power at a very low load, the system increases the burst period (< 800 Hz). The increased burst period is still outside the audible range.

To improve the no load input power and the efficiency at low loads further, the current consumption of the IC is lowered to 235 μ A during the non-switching period in the burst mode.



To achieve a good transient response in burst mode, the system starts switching immediately at an increased output load, allowing a shorter burst period. Eventually, it regulates to the required burst period by increasing the number of driver pulses (see Figure 12).



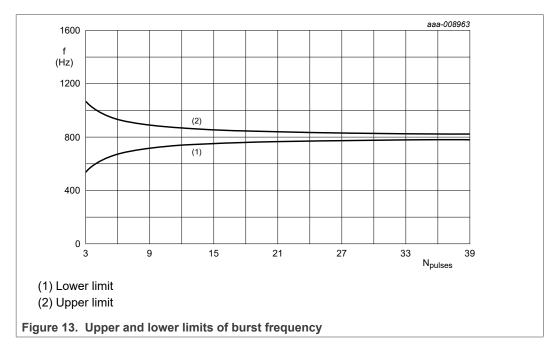
Due to the discrete number of switching cycles, the new calculated number of pulses must be 0.5 higher or lower than the existing number before one switching cycle is added

TEA18361_2

All information provided in this document is subject to legal disclaimers.

© 2022 NXP B.V. All rights reserved

or taken away. For the IC to increase or decrease the number of switching cycles, a certain deviation from the target burst repetition frequency (800 Hz) is required because of the internal algorithm. This deviation becomes smaller when the number of switching cycles increases. Figure 13 shows the upper and lower limits of the burst repetition frequency as a function of the number of pulses.



When the number of driver pulses within one burst period exceeds 40, the system switches to normal mode again.

During the burst period, the voltage on the CTRL pin is clamped to the minimum $V_{\text{clamp}(\text{CTRL})}$. The current out of the CTRL pin is measured. If the current exceeds $I_{\text{stop}(\text{CTRL})}$, the burst period is terminated regardless of digital control. This feature ensures a small overshoot at the output voltage when the load in burst mode suddenly reduces.

At the end of each burst period, the CTRL pin is pulled to the ground level for 12.5 μ s. Unless the current flowing from pin CTRL is below 87 μ A, which usually occurs at a positive load step.

8.8 Soft start-up (ISENSE pin)

To prevent audible noise during start-up or a restart condition, a soft-start feature is implemented. Before the converter starts, the soft-start capacitor C_{SS} on the ISENSE pin is charged. When the converter starts switching, the primary peak current slowly increases as the soft start capacitor discharges through the soft start resistor R_{SS} (see Figure 3).

The external soft-start capacitor and the parallel resistor values set the soft-start time constant.

8.9 Driver (DRIVER pin)

The driver circuit to the gate of the power MOSFET has a current sourcing capability of 300 mA and a current sink capability of 750 mA. These capabilities allow a fast turn-on and turn-off of the power MOSFET for efficient operation.

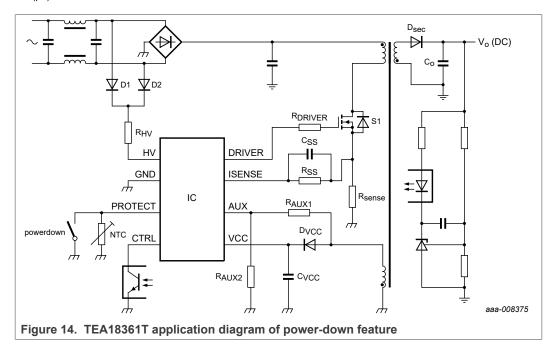
The maximum driver output is limited to 10.5 V. The DRIVER output pin can be connected to the gate of a MOSFET directly or via a resistor.

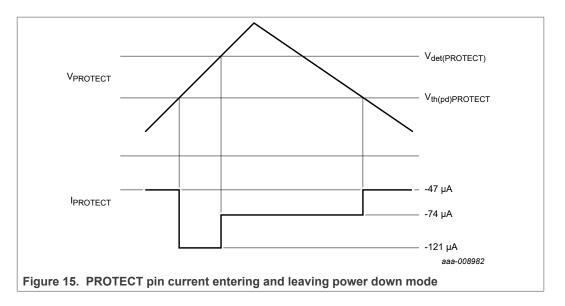
8.10 Power-down mode

To achieve extremely low no-load standby power, the IC can be forced to power-down mode using an external signal on the PROTECT pin (see Figure 14).

When the voltage on the PROTECT pin is pulled below $V_{th(pd)PROTECT}$, the system enters the power-down mode. The voltage on the CTRL pin is lowered to 0 V. The IC automatically runs in burst mode with the voltage on pin VCC regulated at the $V_{restart}$ level. The primary and secondary optocurrent are saved. The current out of the PROTECT pin is reduced from 74 μ A to 47 μ A to save current consumption (See Figure 15).

To avoid that the latched protection is accidentally triggered when the system enters or exits the power-down mode, when the voltage on the PROTECT pin is lower than $V_{th(pd)PROTECT}$, the latched protection is blocked.





9 Limiting values

Table 5. Limiting values
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Voltages					
$V_{IO(HV)}$	input/output voltage on pin HV		-0.4	+700	V
V _{CC}	supply voltage	continuous	-0.4	+30	V
		t < 100 ms	-	+35	V
V _{IO(CTRL)}	input/output voltage on pin CTRL		-0.4	+12	V
$V_{I(ISENSE)}$	input voltage on pin ISENSE		-0.4	+12	V
V _{IO(PROTECT)}	input/output voltage on pin PROTECT	current limited	-0.4	+5	V
V _{IO(AUX)}	input/output voltage on pin AUX	current limited	-5	+5	V
V _{O(DRIVER)}	output voltage on pin DRIVER		-0.4	+12	V
Currents					'
I _{IO(AUX)}	input/output current on pin AUX		-1.5	+1	mA
I _{IO(HV)}	input/output current on pin HV		-1	+5	mA
I _{IO(CTRL)}	input/output current on pin CTRL		-3	0	mA
I _{IO(PROTECT)}	input/output current on pin PROTECT		-1	+1	mA

Table 5. Limiting values...continued In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit	
I _{O(DRIVER)}	output current on pin DRIVER	δ < 10 %		-0.4	+1	A	
General	-		'			<u> </u>	
P _{tot}	total power dissipation	T _{amb} < 75 °C		-	1	W	
T _{stg}	storage temperature			-55	+150	°C	
Tj	junction temperature			-40	+150	°C	
ESD			'	1	'	'	
V _{ESD}	electrostatic discharge	class 1					
	voltage	human body model	[1]				
		pin HV		-1000	+1000	V	
		all other pins		-2000	+2000	V	
		charged device model	[2]	-500	+500	V	

10 Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	in free air; JEDEC test board	73	K/W
R _{th(j-c)}	thermal resistance from junction to case	in free air; JEDEC test board	33.1	K/W

11 Characteristics

Table 7. Characteristics

 T_{amb} = 25 °C; V_{CC} = 20 V; all voltages are measured with respect to ground (pin 2); currents are positive when flowing into the IC; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Start-up current sour	ce (HV pin)					
I _{startup(HV)}	start-up current on pin HV	V _{HV} > 10 V	0.8	1.1	1.4	mA
		V _{CC} > V _{startup} ; HV not sampling	-	-	1	μA
V _{clamp}	clamp voltage	I _{HV} < 2 mA	-	-	680	V
Supply voltage mana	gement (VCC pin)		•			
V _{startup}	start-up voltage		13.4	14.9	16.4	V
V _{restart}	restart voltage	burst mode	9.9	11	12.1	V

TEA18361_2

All information provided in this document is subject to legal disclaimers.

© 2022 NXP B.V. All rights reserved.

Equivalent to discharge a 100 pF capacitor through a 1.5 k Ω series resistor. Equivalent to discharge a 200 pF capacitor through a 0.75 μ H coil and 10 Ω .

Table 7. Characteristics...continued

 T_{amb} = 25 °C; V_{CC} = 20 V; all voltages are measured with respect to ground (pin 2); currents are positive when flowing into the IC; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{th(UVLO)}$	undervoltage lockout threshold voltage		9	9.9	10.8	V
V _{rst}	reset voltage		7.75	8.65	9.55	V
I _{CC(startup)}	start-up supply current	V _{HV} = 0 V	-	40	-	μΑ
		V _{HV} > 10 V	-1.35	-1.05	-0.75	mA
I _{CC(oper)}	operating supply current	driver unloaded; excluding optocurrent	500	600	700	μΑ
I _{CC(burst)}	burst mode supply current	non-switching; excluding optocurrent	200	235	270	μΑ
I _{CC(prot)}	protection supply current		185	220	255	μA
I _{CC(dch)}	discharge supply current	latched protection; V _{CC} > V _{startup}	0.9	1.25	1.6	mA
Mains detect (H	IV pin)				'	
t _{p(HV)}	pulse duration on pin HV	measuring mains voltage	18	20	22	μs
f _{meas(HV)}	measurement frequency on pin	measuring mains voltage	0.9	1.0	1.1	kHz
$t_{d(norm)HV}$	normal mode delay time on pin	measuring mains voltage	5	6	7	ms
t _{d(burst)HV}	burst mode delay time on pin HV	measuring mains voltage	87	97	107	ms
I _{bo(HV)}	brownout current on pin HV		552	587	622	μΑ
I _{bi(HV)}	brownin current on pin HV		623	663	703	μA
I _{bo(hys)} HV	hysteresis of brownout current on pin HV		-	76	-	μA
I _{IH(HV)}	HIGH-level input current on pin		1186	1262	1338	μA
I _{IL(HV)}	LOW-level input current on pin		1118	1190	1262	μΑ
I _{HL(hys)HV}	HIGH to LOW hysteresis current on pin HV		-	72	-	μΑ
I _{clamp(HV)}	clamp current on pin HV	during measurement time	-	-	1.7	mA
V _{meas(HV)}	measurement voltage on pin	brownin/brownout	-	2.6	-	V
t _{d(dch)}	discharge delay time	X-capacitor discharge; pin HV	-	28	-	ms
t _{d(det)bo}	brownout detection delay time		-	30	-	ms
Peak current co	ontrol (pin CTRL)	•	-		1	
V _{IO(CTRL)}	input/output voltage on pin	minimum flyback peak current	2.3	2.5	2.7	V
	CTRL	maximum flyback current	4.9	5.25	5.6	V
R _{int(CTRL)}	internal resistance on pin CTRL		10	12	14	kΩ

TEA18361_2

All information provided in this document is subject to legal disclaimers.

© 2022 NXP B.V. All rights reserved.

Table 7. Characteristics...continued

 T_{amb} = 25 °C; V_{CC} = 20 V; all voltages are measured with respect to ground (pin 2); currents are positive when flowing into the IC; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
I _{IO(CTRL)}	input/output current on pin	normal mode					
	CTRL	V _{CTRL} = 1.5 V	-0.58	-0.48	-0.38	mA	
		V _{CTRL} = 3.5 V	-0.385	-0.315	-0.245	mA	
V _{startup(CTRL)}	start-up voltage on pin CTRL		4.7	5	5.3	V	
Burst mode (pin	CTRL)						
V _{th(burst)}	burst mode threshold voltage		0.42	0.5	0.58	V	
T _{burst}	burst mode period		-	1250	-	μs	
f _{sw(min)}	minimum switching frequency	burst mode	23	25	27	kHz	
I _{regd(CTRL)}	regulated current on pin CTRL	burst mode	-115	-100	-85	μΑ	
V _{clamp(CTRL)}	clamp voltage on pin CTRL	burst mode; system switching	0.44	0.5	0.56	V	
I _{stop(CTRL)}	stop current on pin CTRL	burst mode; system switching; including regulated output current	-820	-750	-680	μА	
t _{pd(CTRL)}	pull-down time on pin CTRL		10	12.5	15	μs	
I _{det(CTRL)}	detection current on pin CTRL	positive load step	65	80	95	μΑ	
		disable pulling down the CTRL pin	77	87	97	μΑ	
Oscillator	·			•			
f _{sw(max)}	maximum switching frequency		125	132.5	140	kHz	
f _{sw(min)}	minimum switching frequency		23	25	27	kHz	
V _{start(red)f}	frequency reduction start voltage	pin CTRL	2.3	2.5	2.7	V	
Current sense (p	oin ISENSE)		'				
V _{sense(max)}	maximum sense voltage	Δ V/ Δ t = 0 V/s; I _{AUX} = 0 μA; V _{CTRL} = 5.5 V	700	765	830	mV	
		frequency reduction mode; $\Delta V/\Delta t = 0$ mV/ μ s; $I_{AUX} = 0$ μ A; $V_{CTRL} = 1.0$ V	190	207	225	mV	
t _{PD(sense)}	sense propagation delay	from the ISENSE pin reaching $V_{sense(max)}$ to driver off; V_{ISENSE} pulse-stepping 100 mV around $V_{sense(max)}$	-	120	-	ns	
t _{leb}	leading-edge blanking time		275	325	375	ns	
Soft start (pin IS	ENSE)					•	
I _{start(soft)}	soft start current		-85	-75	-65	μA	
V _{start(soft)}	soft start voltage	enable voltage	-	V _{sense(m}	axī)	V	
R _{start(soft)}	soft start resistance		12	-	-	kΩ	

Table 7. Characteristics...continued

 T_{amb} = 25 °C; V_{CC} = 20 V; all voltages are measured with respect to ground (pin 2); currents are positive when flowing into the IC; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Demagnetization	and valley control (pin AUX)					
V _{det(demag)}	demagnetization detection voltage		20	35	50	mV
I _{prot(AUX)}	protection current on pin AUX		-	-200	-	nA
t _{blank(det)demag}	demagnetization detection blanking time		1.8	2.2	2.6	μs
(ΔV/Δt) _{vrec}	valley recognition voltage	positive ΔV/Δt	0.25	0.37	0.49	V/µs
	change with time	negative ΔV/Δt	-2.35	-1.9	-1.45	V/µs
t _{d(vrec-swon)}	valley recognition to switch-on delay time		-	120	-	ns
V _{clamp(AUX)}	clamp voltage on pin AUX	I _{AUX} = 1 mA	4.4	4.8	5.2	V
t _{sup(xfmr_ring)}	transformer ringing suppression time		1.9	2.3	2.7	μs
Maximum on-time	e (pin DRIVER)					
t _{on(max)}	maximum on-time		45	55	65	μs
Driver (pin DRIVE	ER)				•	
I _{source(DRIVER)}	source current on pin DRIVER	V _{DRIVER} = 2 V	-	-0.3	-0.25	Α
I _{sink(DRIVER)}	sink current on pin DRIVER	V _{DRIVER} = 2 V	0.25	0.3	-	Α
		V _{DRIVER} = 10 V	0.6	0.75	-	Α
V _{O(DRIVER)max}	maximum output voltage on pin DRIVER		9	10.5	12	V
Overpower comp	ensation (pin ISENSE and pin AUX)					
V _{clamp(AUX)}	clamp voltage on pin AUX	primary stroke; I _{AUX} = −0.3 mA	-0.8	-0.7	-0.6	V
t _{d(clamp)} AUX	clamp delay time on pin AUX	after rising edge of pin DRIVER	580	665	750	ns
		after falling edge of pin DRIVER	1.8	2.2	2.6	μs
V _{opc(ISENSE)}	overpower compensation	I _{AUX} = −0.3 mA	700	765	830	mV
	voltage on pin ISENSE	I _{AUX} = −1.46 mA	400	450	500	mV
V _{opp(ISENSE)}	overpower protection voltage	counter trigger level				
	on pin ISENSE	I _{AUX} = −0.3 mA	450	500	550	mV
		I _{AUX} = −1.46 mA	265	295	325	mV
t _{d(opp)}	overpower protection delay time	start-up mode; V _{CTRL} > 5 V	36	40	44	ms
		normal mode	180	200	220	ms
t _{d(restart)}	restart delay time		720	800	820	ms
External protection	on (pin PROTECT)				'	
V _{det(PROTECT)}	detection voltage on pin PROTECT		0.47	0.5	0.53	V

Table 7. Characteristics...continued

 T_{amb} = 25 °C; V_{CC} = 20 V; all voltages are measured with respect to ground (pin 2); currents are positive when flowing into the IC; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{det(hys)} PROTECT	hysteresis of detection voltage on pin PROTECT		-	50	-	mV
I _{O(PROTECT)}	output current on pin PROTECT	normal mode	-79	-74	-69	μΑ
		power-down mode	-55	-47	-40	μA
V _{clamp(PROTECT)}	clamp voltage on pin PROTECT		1.25	1.45	1.65	V
Power-down mode	e (pin PROTECT)			'	'	'
V _{th(pd)} PROTECT	power-down threshold voltage on pin PROTECT			0.2	0.22	V
V _{hys(pd)}	power-down hysteresis voltage		-	20	-	mV
Overvoltage prote	ection (pin AUX)		1	'		'
$V_{\text{ovp}(AUX)}$	overvoltage protection voltage on pin AUX		2.88	3	3.12	V
t _{det(ovp)}	overvoltage protection detection time	in the secondary stroke	1.9	2.3	2.7	μs
Temperature prote	ection		'			,
T _{pl(IC)}	IC protection level temperature		130	140	150	°C

12 Application information

A power supply with TEA18361T is a flyback converter operating in QR mode or DCM (See Figure 3).

Capacitor C_{VCC} buffers the IC supply voltage. The IC supply voltage is powered from the mains via D1, D2, R_{HV} during start-up. It is powered via the auxiliary winding during normal operation. R_{HV} defines the current into the HV pin for brownout detection and mains detection.

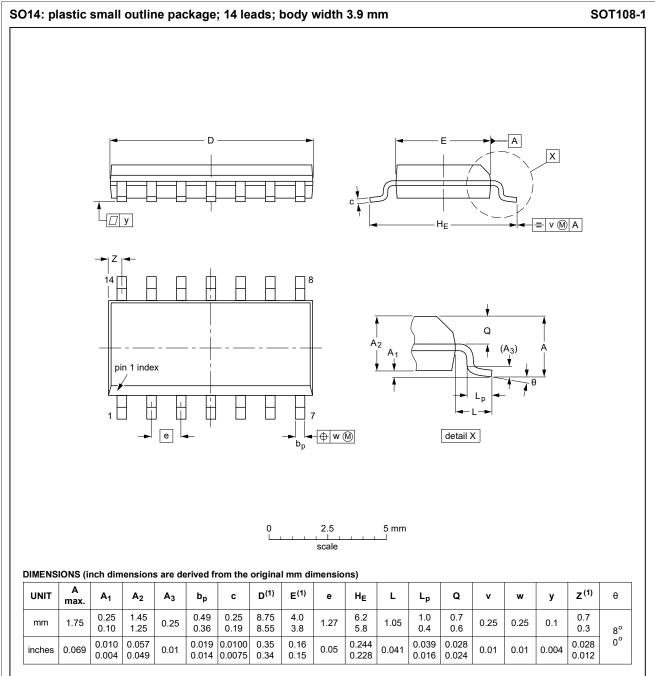
Sense resistor R_{sense} converts the current through MOSFET S1 into a voltage on pin ISENSE. The value of R_{sense} defines the maximum primary peak current through MOSFET S1. Resistor R_{SS} and capacitor C_{SS} define the soft start time.

Resistor R_{DRIVER} is required to limit the current spikes to pin DRIVER because of parasitic inductance of the current sense resistor R_{sense} . R_{DRIVER} also dampens possible oscillation of MOSFET S1. Adding a bead on the gate pin of MOSFET S1 can be required to prevent local oscillations of the MOSFET.

The PROTECT pin can be connected to a negative temperature coefficient (NTC) resistor. The protection is activated when the resistor drops below a value of $V_{\text{det(PROTECT)}} / I_{O(PROTECT)} = 6.7 \text{ k}\Omega$. Shorting the PROTECT pin to ground by an external switch or optocoupler can activate the power-down mode.

The resistor R_{AUX2} determines the compensation for input voltage variation. The ratio of R_{AUX1} and R_{AUX2} determines the overvoltage protection at the AUX pin.

13 Package outline



Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE	REFERENCES			EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT108-1	076E06	MS-012				99-12-27 03-02-19	

Figure 16. Package outline SOT108-1 (SO14)

TEA18361_2

All information provided in this document is subject to legal disclaimers.

© 2022 NXP B.V. All rights reserved.

TEA18361T/2

GreenChip SMPS control IC

14 Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
TEA18361T_2 v.1	20221121	Product data sheet	-	-

15 Legal information

15.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

15.2 Definitions

Draft — A draft status on a document indicates that the content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included in a draft version of a document and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

15.3 Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

TEA18361_2

All information provided in this document is subject to legal disclaimers.

© 2022 NXP B.V. All rights reserved.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Suitability for use in non-automotive qualified products — Unless this data sheet expressly states that this specific NXP Semiconductors product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. NXP Semiconductors accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications.

In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without NXP Semiconductors' warranty of the product for such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond NXP Semiconductors' specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies NXP Semiconductors for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond NXP Semiconductors' standard warranty and NXP Semiconductors' product specifications.

Translations — A non-English (translated) version of a document, including the legal information in that document, is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

Security — Customer understands that all NXP products may be subject to unidentified vulnerabilities or may support established security standards or specifications with known limitations. Customer is responsible for the design and operation of its applications and products throughout their lifecycles to reduce the effect of these vulnerabilities on customer's applications and products. Customer's responsibility also extends to other open and/or proprietary technologies supported by NXP products for use in customer's applications. NXP accepts no liability for any vulnerability. Customer should regularly check security updates from NXP and follow up appropriately. Customer shall select products with security features that best meet rules, regulations, and standards of the intended application and make the ultimate design decisions regarding its products and is solely responsible for compliance with all legal, regulatory, and security related requirements concerning its products, regardless of any information or support that may be provided by NXP.

NXP has a Product Security Incident Response Team (PSIRT) (reachable at PSIRT@nxp.com) that manages the investigation, reporting, and solution release to security vulnerabilities of NXP products.

15.4 Trademarks

Notice: All referenced brands, product names, service names, and trademarks are the property of their respective owners.

NXP — wordmark and logo are trademarks of NXP B.V.

GreenChip — is a trademark of NXP B.V.